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Application/Control No.	Applicant(s)/Patent under Reexamination
09/879,583	WIPFEL ET AL.
Examiner	Art Unit
Yemane M. Gerezgiher	2144

	SEAR	CHED	
Class	Subclass	Date	Examiner
709	.208,213	4/14/2005	YMG
709	223,224	4/14/2005	YMG-
709	226,229	4/14/2005	YMG
714	4,37,43	4/14/2005	YMG
709	201,220	4/15/2005	YMG
709	223,248	4/15/2005	YMG
714	15	4/15/2005	YMG
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
709	224	4/14/2005	YMG
709	201,248	4/15/2005	YMG
714	4, 15	4/15/2005	YMG

SEARCH NO (INCLUDING SEARCH		
	DATE	EXMR
Updated East Keyword search	4/14/2005	YMG
NPL (IEEE, CiteSeer, Google)	4/15/2005	YMG
Consulted with Primary Examiner Marc D. Thompson	2/23/2005	YMG
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